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ROUND TYPE LED LAMPS

**LSBK2042S**

DATA SHEET

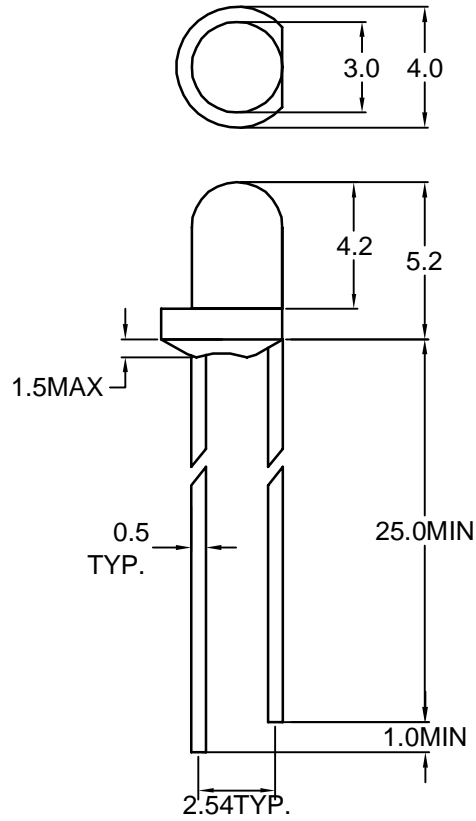
DOC. NO : QW0905-LSBK2042S

REV. : A

DATE : 17 - Jan - 2005

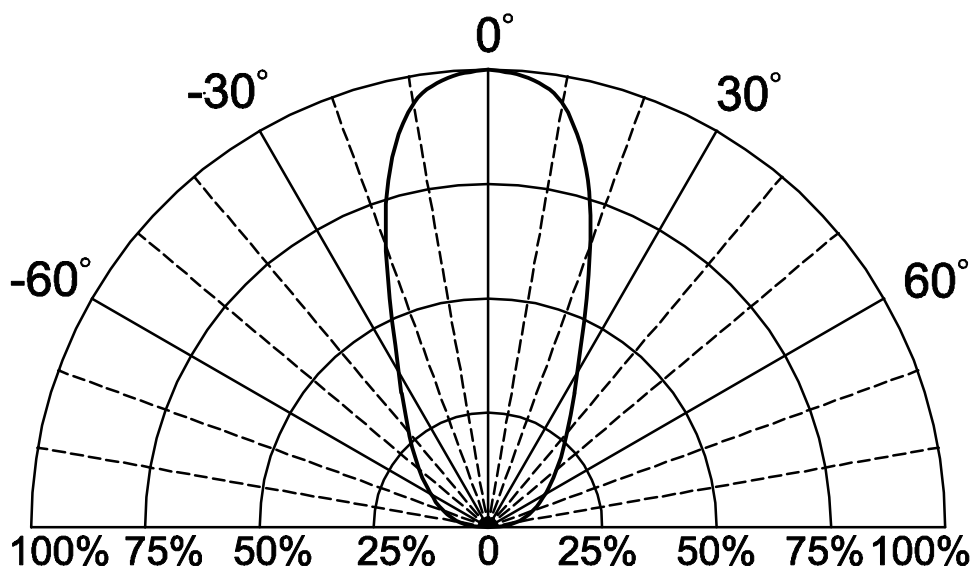


### Package Dimensions



Note : 1.All dimension are in millimeter tolerance is  $\pm 0.25\text{mm}$  unless otherwise noted.  
2.Specifications are subject to change without notice.

### Directivity Radiation





## Absolute Maximum Ratings at Ta=25

| Parameter                               | Symbol | Ratings                                  | UNIT |
|-----------------------------------------|--------|------------------------------------------|------|
|                                         |        | SBKS                                     |      |
| Forward Current                         | IF     | 30                                       | mA   |
| Peak Forward Current<br>Duty 1/10@10KHz | IFP    | 100                                      | mA   |
| Power Dissipation                       | PD     | 120                                      | mW   |
| Reverse Current @5V                     | Ir     | 50                                       | μ A  |
| Electrostatic Discharge                 | ESD    | 500                                      | V    |
| Operating Temperature                   | Topr   | -20 ~ +80                                |      |
| Storage Temperature                     | Tstg   | -30 ~ +100                               |      |
| Soldering Temperature                   | Tsol   | Max 260 for 5 sec Max<br>(2mm from body) |      |

## Typical Electrical &amp; Optical Characteristics (Ta=25 )

| PART NO   | MATERIAL  | COLOR   |                | Dominant wave length<br>Dnm | Spectral halfwidth<br>nm | Forward voltage<br>@20mA(V) |      | Luminous intensity<br>@20mA(mcd) |      | Viewing angle<br>2 1/2<br>(deg) |
|-----------|-----------|---------|----------------|-----------------------------|--------------------------|-----------------------------|------|----------------------------------|------|---------------------------------|
|           |           | Emitted | Lens           |                             |                          | Typ.                        | Max. | Min.                             | Typ. |                                 |
| LSBK2042S | InGaN/SiC | Blue    | White Diffused | 475                         | 26                       | 3.5                         | 4.2  | 220                              | 550  | 50                              |

Note : 1.The forward voltage data did not including  $\pm 0.1V$  testing tolerance.

2. The luminous intensity data did not including  $\pm 15\%$  testing tolerance.

## Typical Electro-Optical Characteristics Curve

SBK CHIP

Fig.1 Forward current vs. Forward Voltage

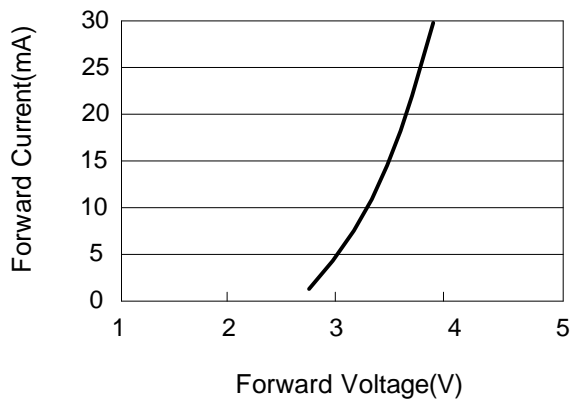


Fig.2 Relative Intensity vs. Forward Current

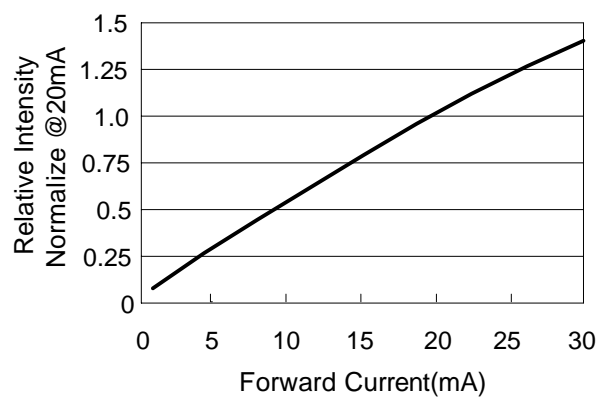


Fig.3 Forward Current vs. Temperature

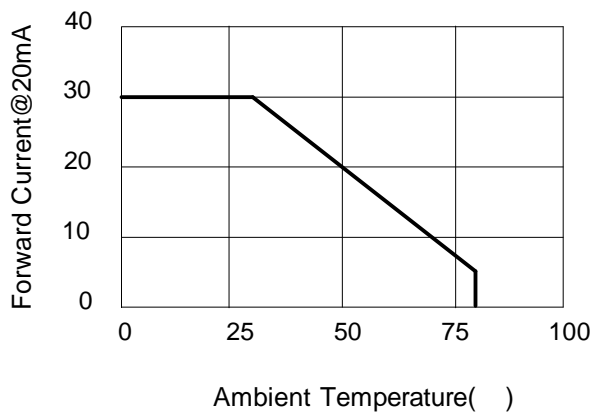
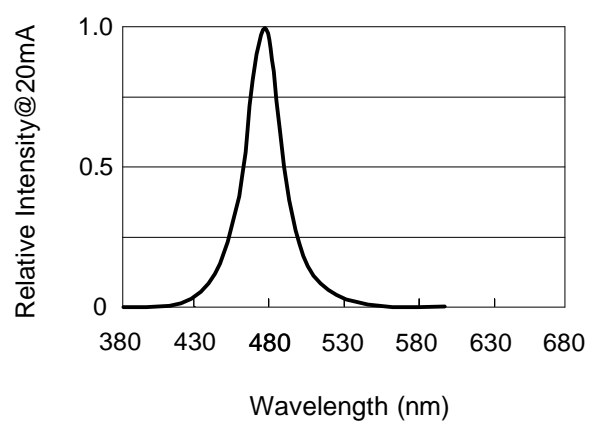


Fig.4 Relative Intensity vs. Wavelength





## Reliability Test:

| Test Item                           | Test Condition                                                         | Description                                                                                                                                                             | Reference Standard                                                             |
|-------------------------------------|------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------|
| Operating Life Test                 | 1.Under Room Temperature<br>2.If=20mA<br>3.t=1000 hrs (-24hrs, +72hrs) | This test is conducted for the purpose of detemining the resisance of a part in electrical and themal stressed.                                                         | MIL-STD-750: 1026<br>MIL-STD-883: 1005<br>JIS C 7021: B-1                      |
| High Temperature Storage Test       | 1.Ta=105 ±5<br>2.t=1000 hrs (-24hrs, +72hrs)                           | The purpose of this is the resistance of the device which is laid under ondition of hogh temperature for hours.                                                         | MIL-STD-883:1008<br>JIS C 7021: B-10                                           |
| Low Temperature Storage Test        | 1.Ta=-40 ±5<br>2.t=1000 hrs (-24hrs, +72hrs)                           | The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.                                                         | JIS C 7021: B-12                                                               |
| High Temperature High Humidity Test | 1.Ta=65 ±5<br>2.RH=90%~95%<br>3.t=240hrs ±2hrs                         | The purpose of this test is the resistance of the device under tropical for hous.                                                                                       | MIL-STD-202:103B<br>JIS C 7021: B-11                                           |
| Thermal Shock Test                  | 1.Ta=105 ±5 & -40 ±5<br>(10min) (10min)<br>2.total 10 cycles           | The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.                                                              | MIL-STD-202: 107D<br>MIL-STD-750: 1051<br>MIL-STD-883: 1011                    |
| Solder Resistance Test              | 1.T.Sol=260 ±5<br>2.Dwell time= 10 ±1sec.                              | This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire. | MIL-STD-202: 210A<br>MIL-STD-750: 2031<br>JIS C 7021: A-1                      |
| Solderability Test                  | 1.T.Sol=230 ±5<br>2.Dwell time=5 ±1sec                                 | This test intended to see soldering well performed or not.                                                                                                              | MIL-STD-202: 208D<br>MIL-STD-750: 2026<br>MIL-STD-883: 2003<br>JIS C 7021: A-2 |